

*Improved Prism Array for Electron Beam Inspection
and Defect Review*

Inventor(s): Marian Mankos
Atty Docket No. 10011.002400 (P1266)

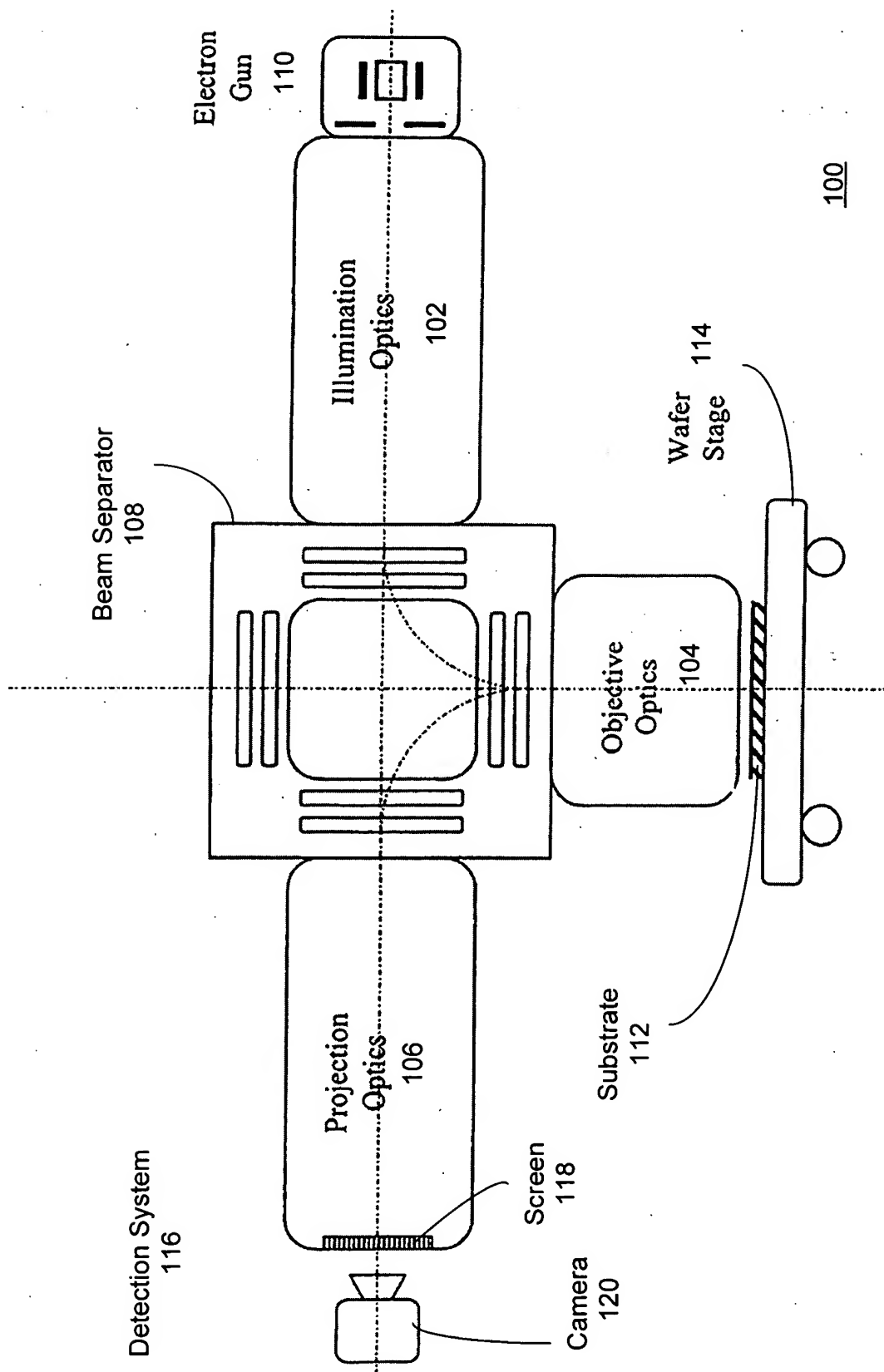
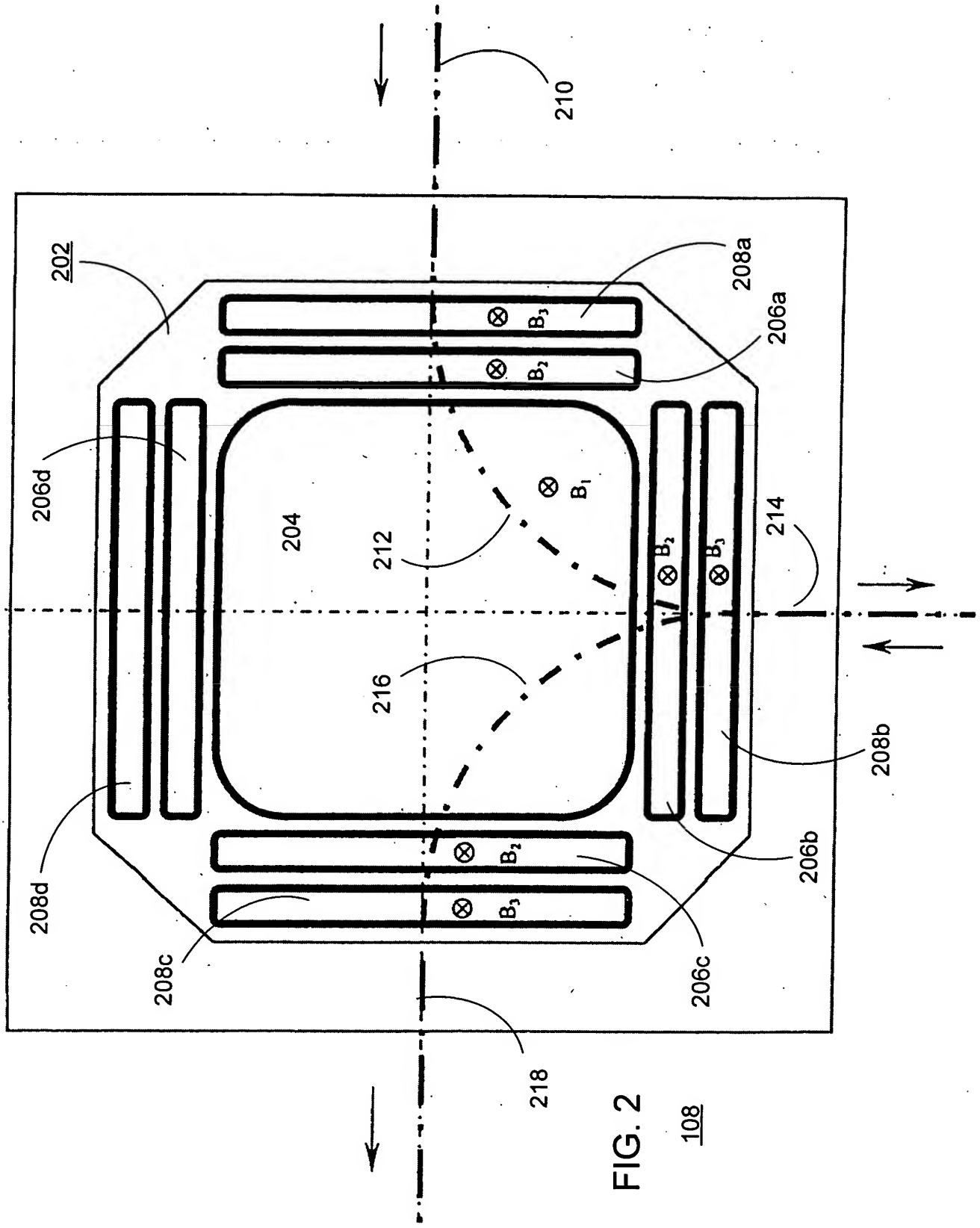


FIG. 1



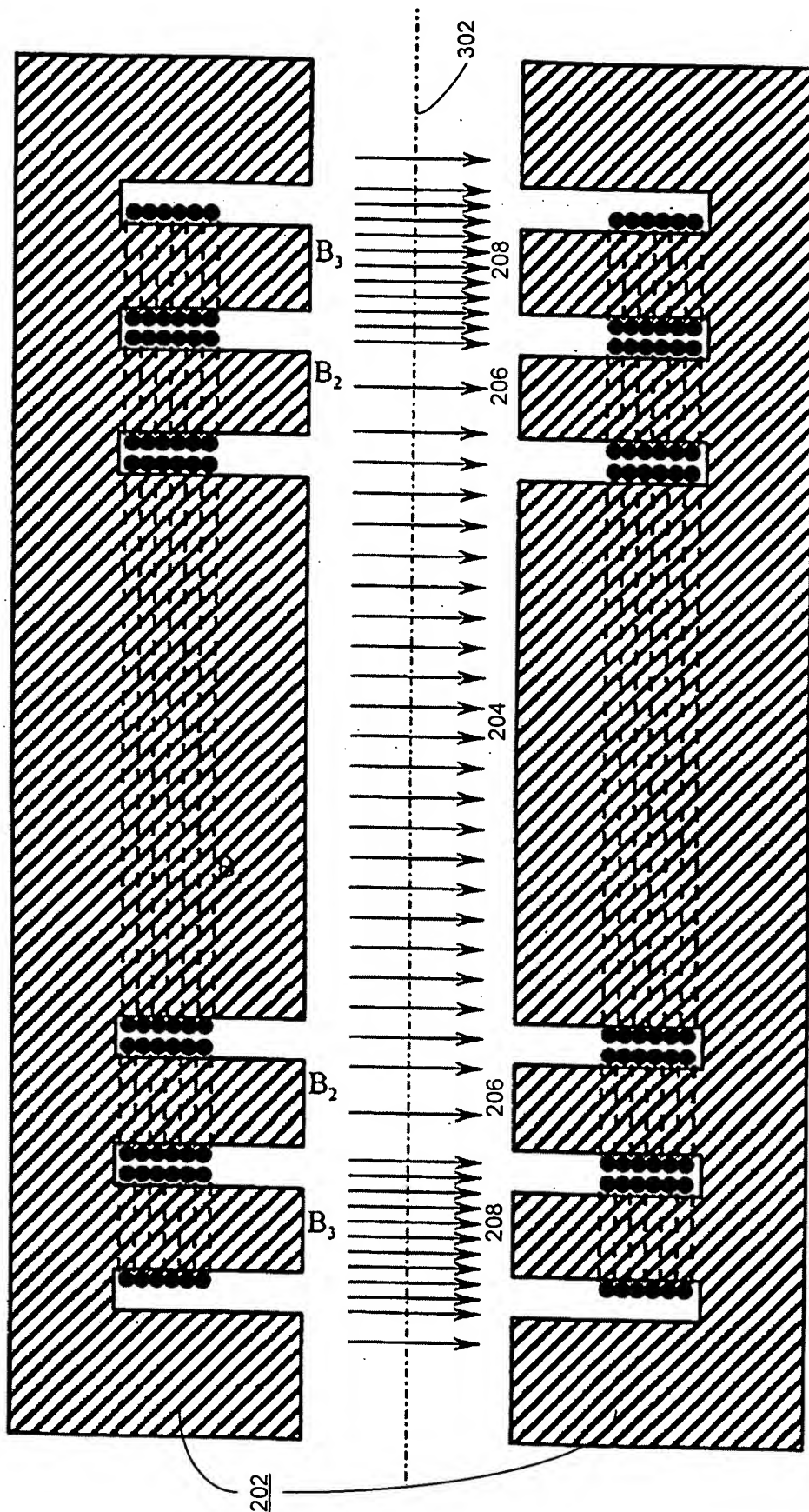


FIG. 3

